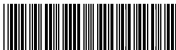


Search Notes**Application/Control No.**

10/737,225

Examiner

Anthony Weier

**Applicant(s)/Patent under
Reexamination**

GANDHI ET AL.

Art Unit

1794

SEARCHED

Class	Subclass	Date	Examiner
updated	previous search	1/30/2008	AW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR